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Title: Phase Identification and Twinning

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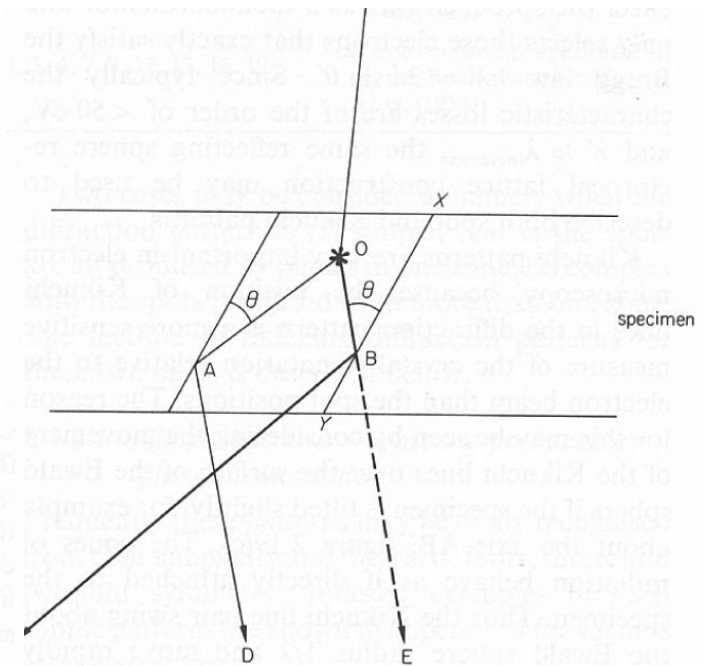
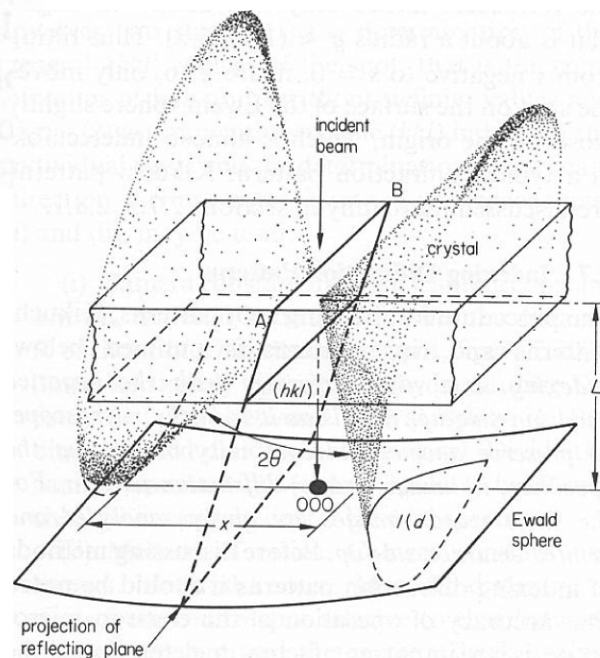
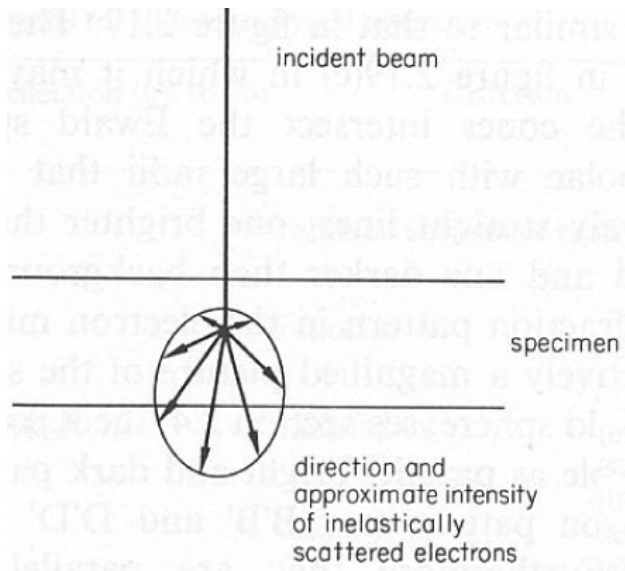
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Phase Identification and Twinning

R.D. Field, Los Alamos National Laboratory

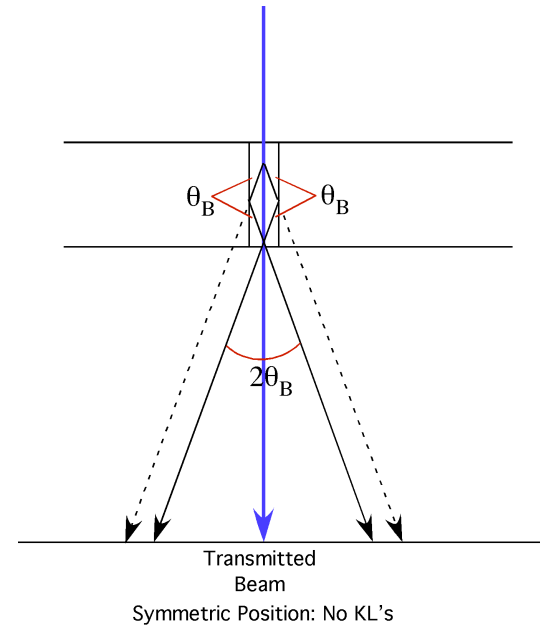
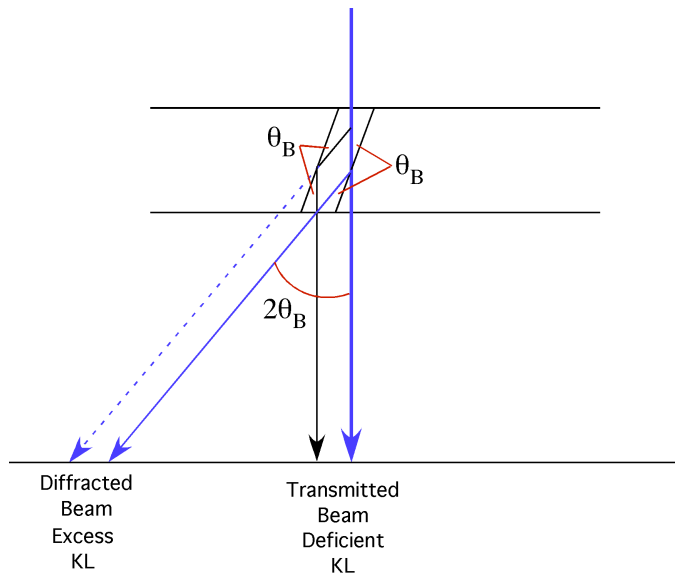
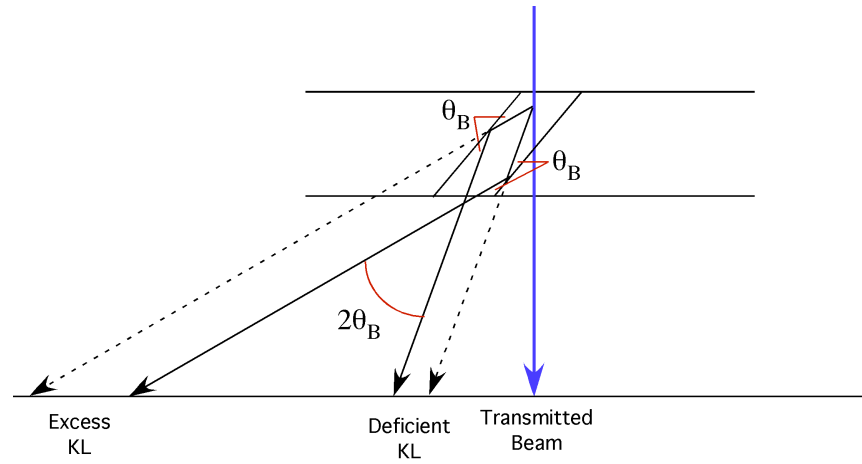
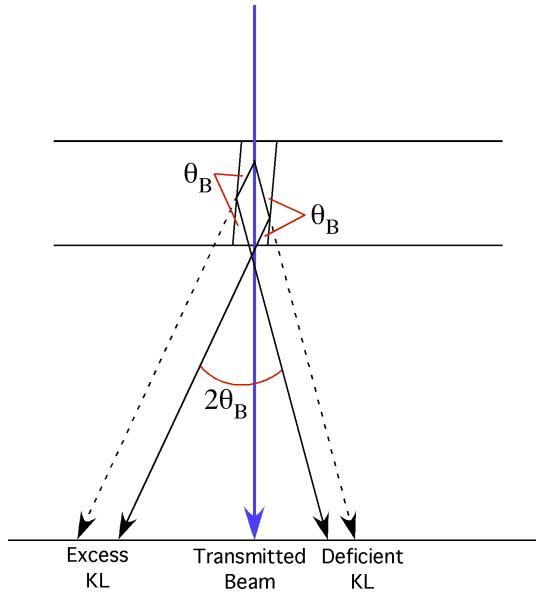
- Tilting in the TEM
 - Kikuchi lines: your map to reciprocal space
 - Tips for tilting
- Diffraction patterns and indexing
 - A little crystallography
 - Tips for indexing
- Orientation relationships and variants
 - Single variant
 - Multiple variant
 - Twins
- Miscellaneous examples

Kikuchi Lines: Road Maps of Reciprocal Space



(Figures from Edington, "Practical Electron Microscopy in Materials Science")

Kikuchi Line Formation



Experimental Kikuchi Patterns

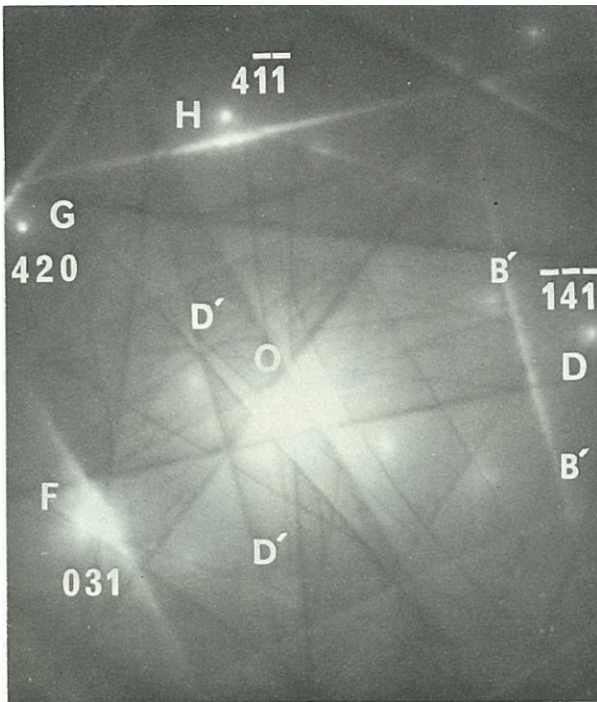
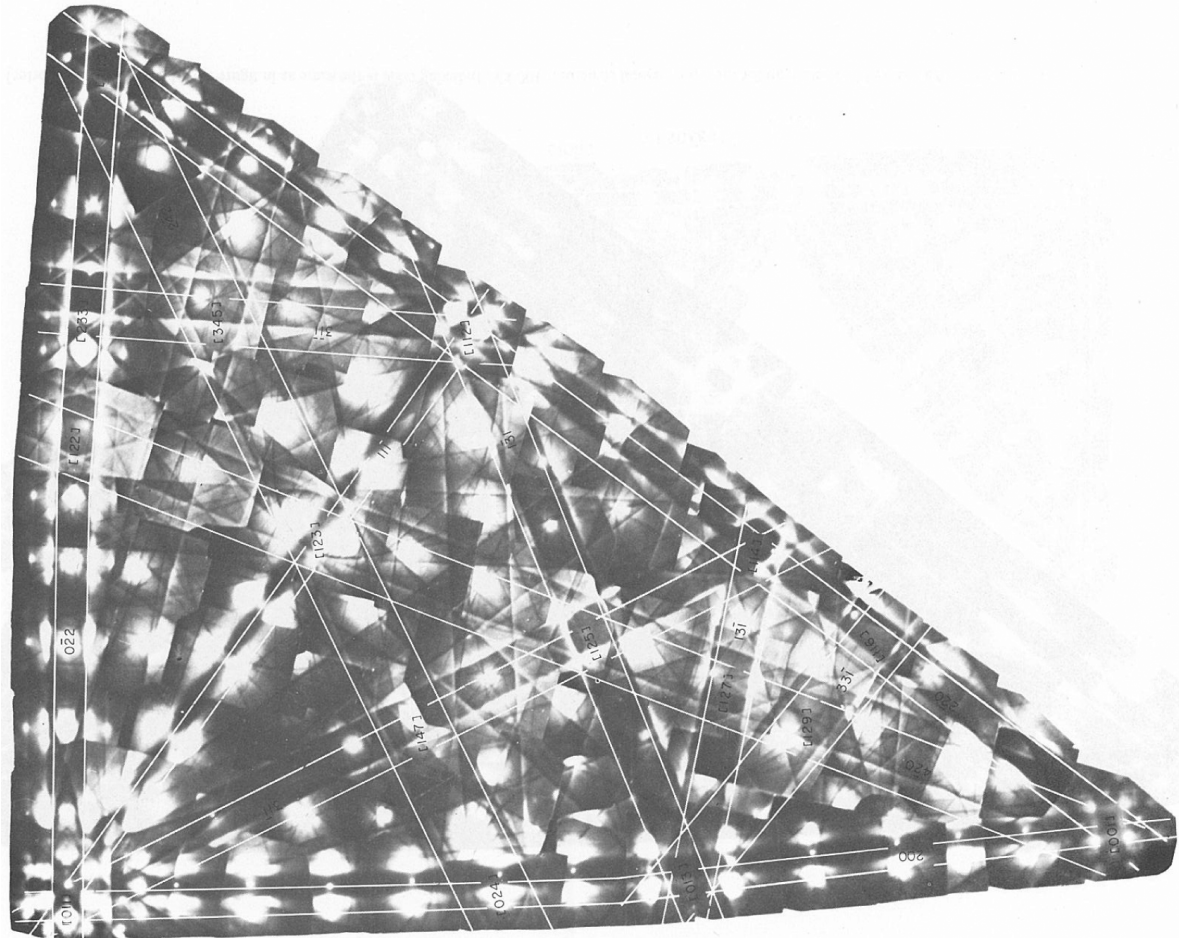


Figure 2.22 A combined spot and Kikuchi line pattern from fully annealed α -iron showing two zones of spots [Courtesy of C. A. Shell]

Kikuchi lines

(Figure from Loretto and Smallman, "Defect Analysis in Electron Microscopy")



Kikuchi map of fcc (montage)

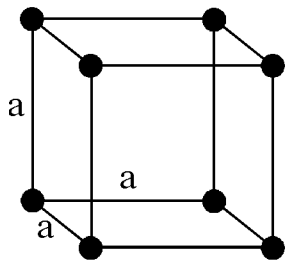
(Figure from Edington, "Practical Electron Microscopy in Materials Science")

Figure A5.1 An indexed Kikuchi map for the f.c.c. crystal structure; 100 kV. The indices in square brackets are those of the beam direction B for the particular Kikuchi line pattern. The unbracketed indices are those for the Kikuchi line pair [Courtesy of A. Samuelson]

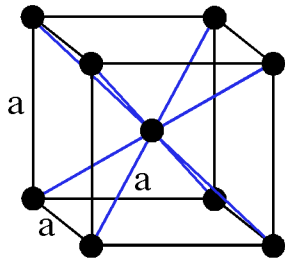
Tilting Tips

- Tilt in CBED mode
 - defocus condenser lens to see image in discs
- Follow short g-vectors and mirror planes
- Follow more than one g-vector
 - “turn a corner”
- Record tilts between zone axes
 - one more thing to fit to phase information

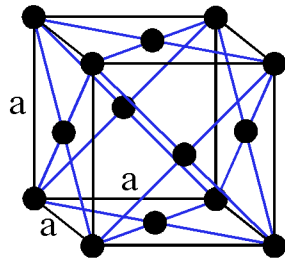
Major Symmetry Operations



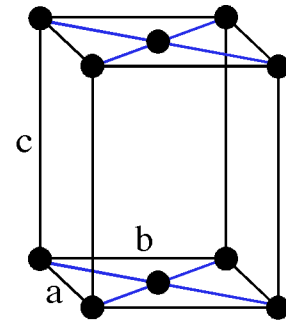
Simple (Primitive)
Cubic (P)



Body-Centered
Cubic (I)



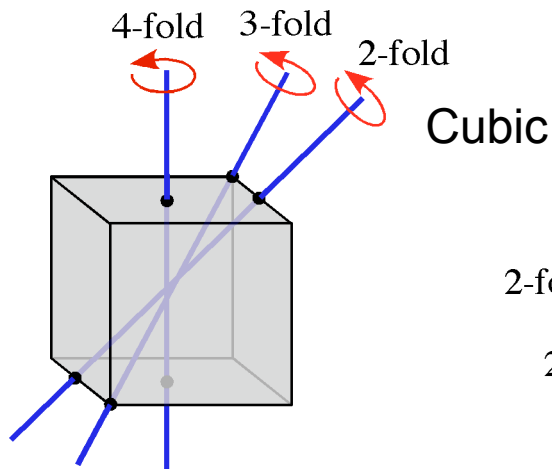
Face-Centered
Cubic (F)



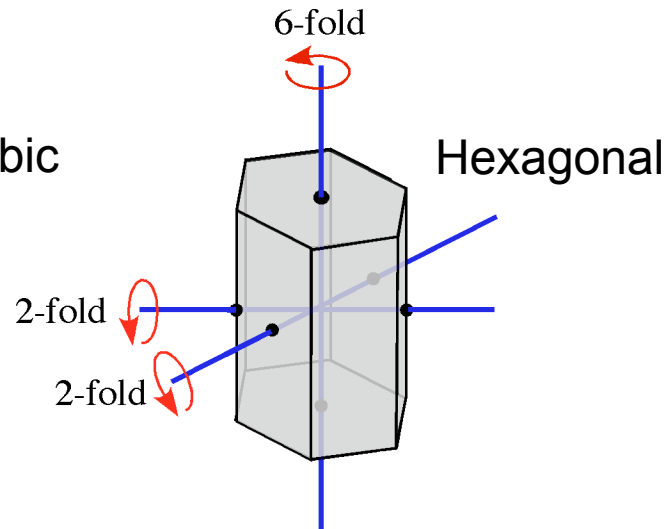
Base-Centered
Orthorhombic (C)

Cell Centering
(P,I,F,C,R[†])

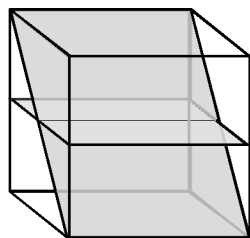
[†] Rhombohedral



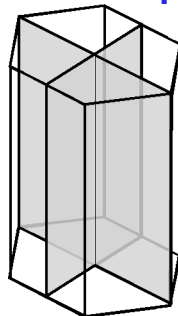
Cubic



Hexagonal



Cubic



Hexagonal

Rotation Axes
(2,3,4,6)

or

Screw Axes

(e.g. 2₁, 3₁, 4₁, 6₃)

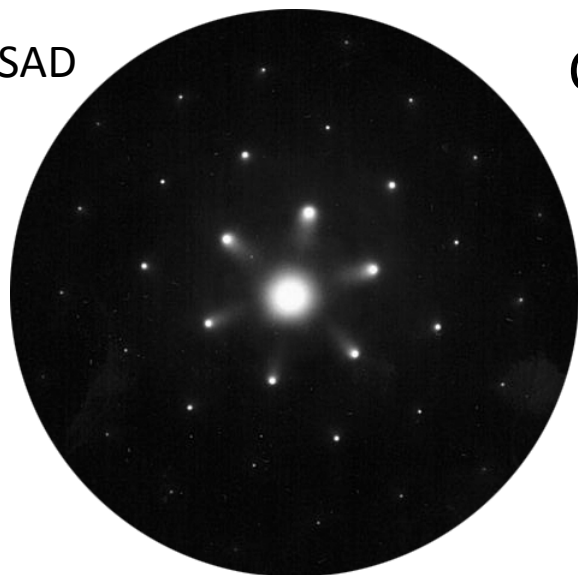
Mirror Planes (m)

or

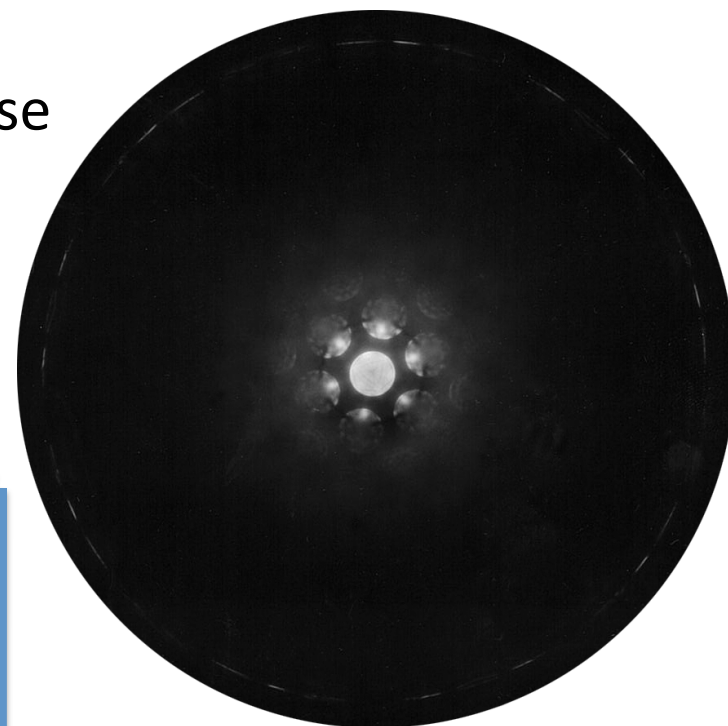
Glide Planes

(a,c,n,d)

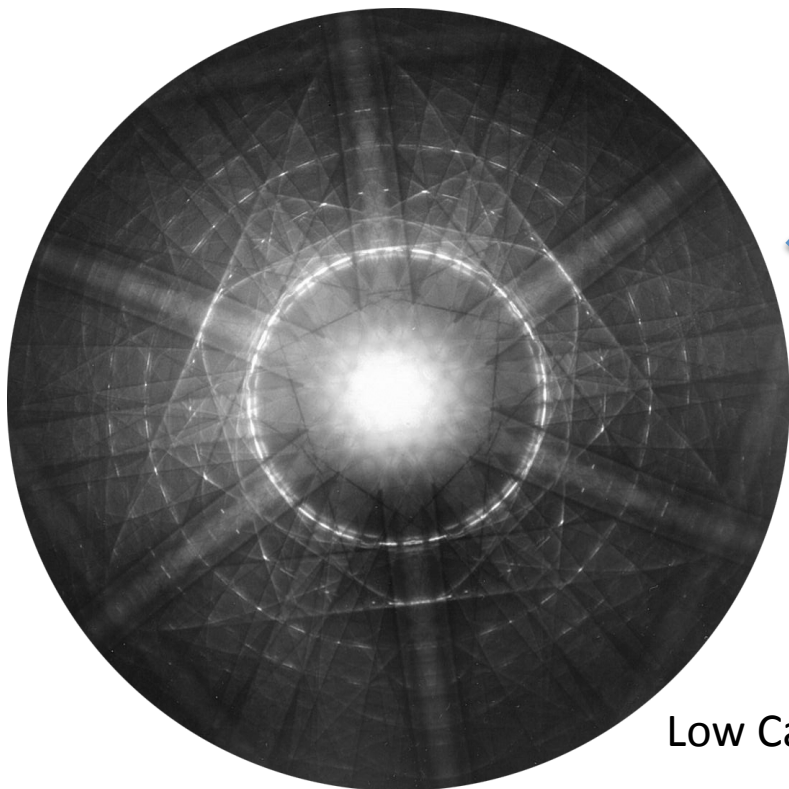
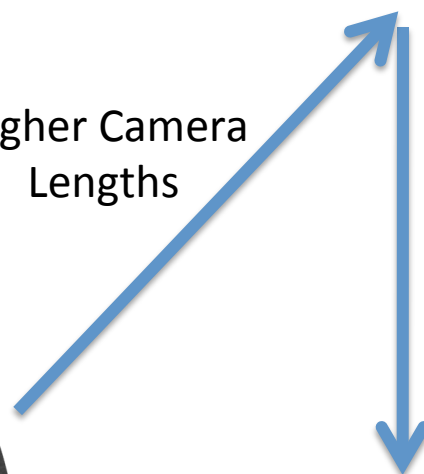
SAD



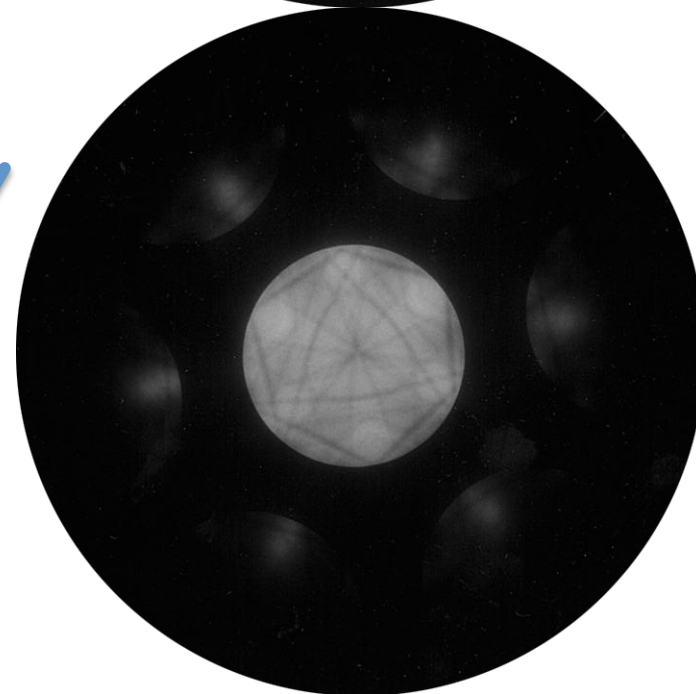
CBED of Fd-3m Phase
(Diamond Cubic)



Higher Camera
Lengths



Low Camera Length

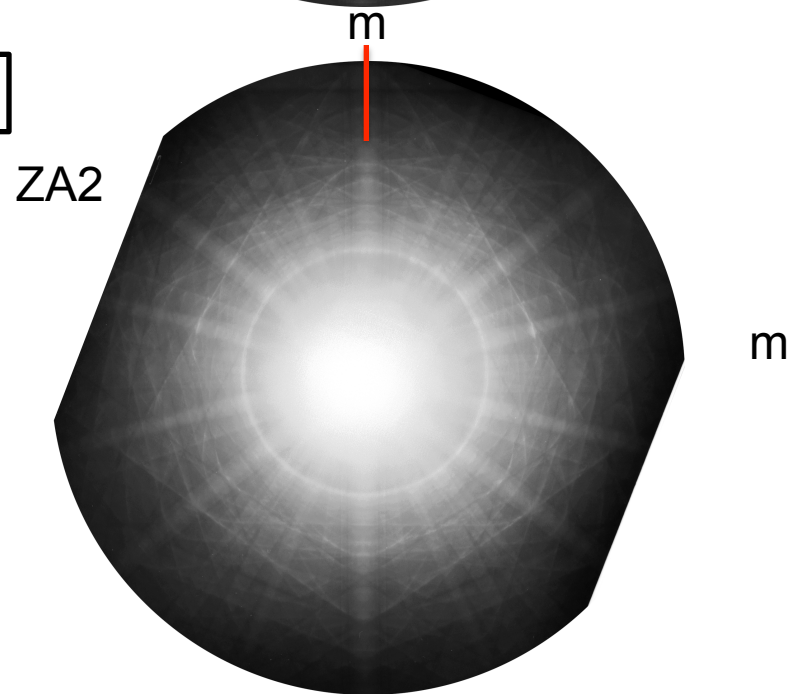
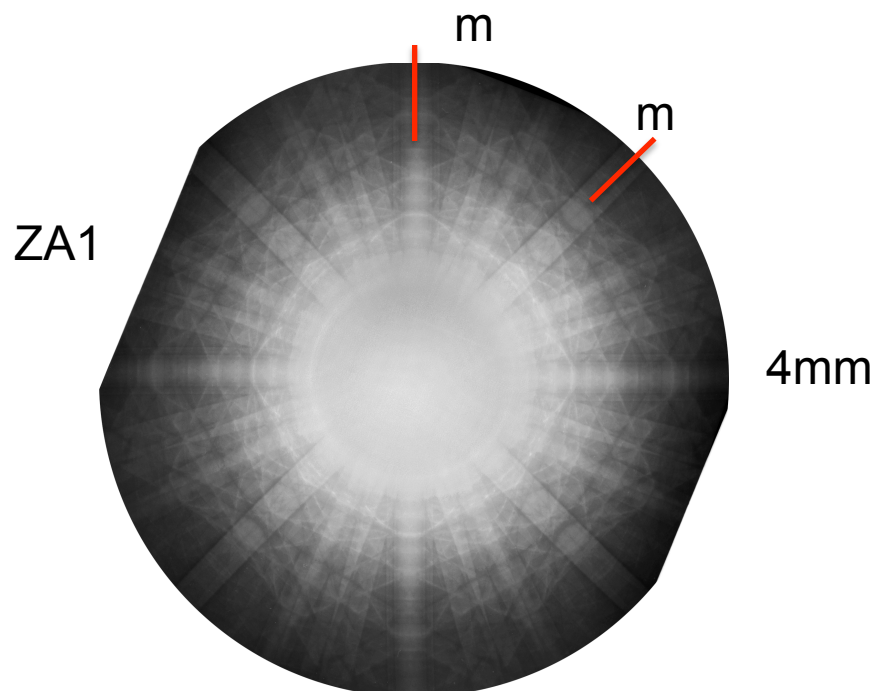
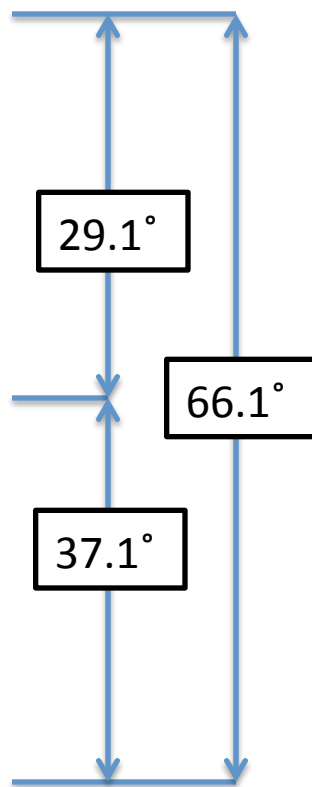
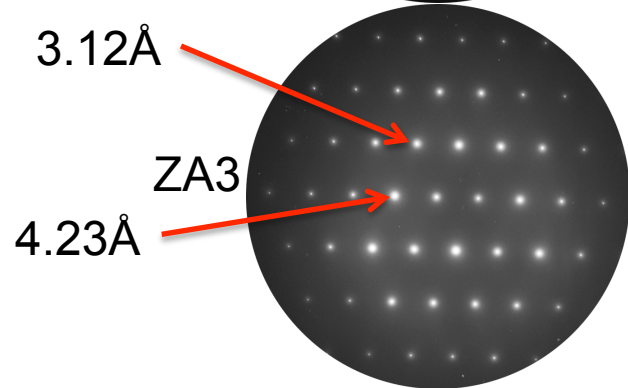
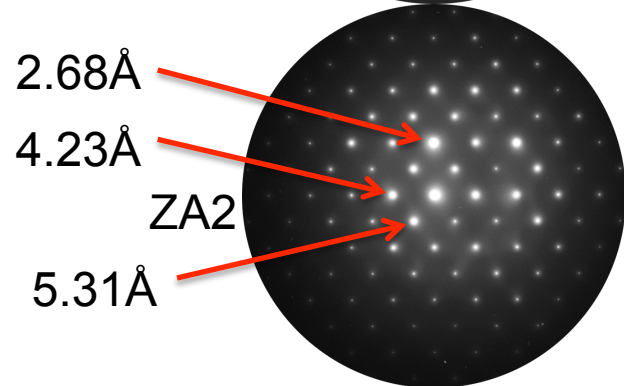
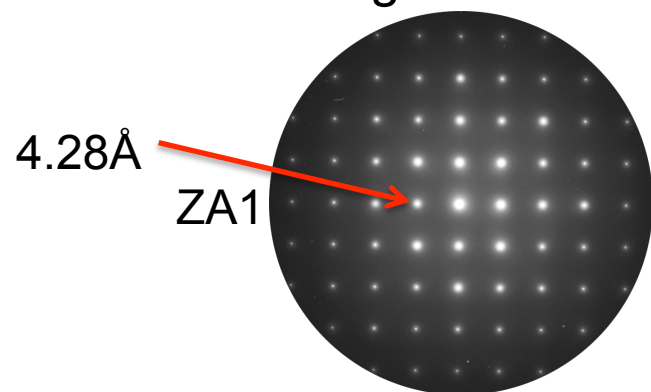


Indexing Diffraction Patterns

- Measure d-spacings from reflections (SAD)
 - calibrated instrument
 - note that precision is in the $\pm 0.1\text{\AA}$ range (SAD)
 - generally 2 g-vectors is sufficient per zone axis
- Angles between reflections can be useful
 - for low symmetry zone axes
- Note symmetry (CBED)
 - will limit which planes to consider
- Compare to known/proposed phase data
 - d-spacing
 - symmetry considerations
 - extinctions

Indexing Example: Mo_5SiB_2

Accumulating the Data



Indexing Example: $\text{Mo}_5\text{SiB}_2^\dagger$

Fitting the Data

D-spacing measurements

d-meas.	ZA	plane	d-calc.	Allowed/ Double Diffr.	Extinction Rule ^{††}
4.28/4.23	1,2,3	1-10	4.24	Allowed	NA
5.31	1	10-1	5.27	DD	hkl: $h+k+l = 2n$
3.35	2	11-2	3.36	Allowed	NA
3.12	3	10-3	3.13	DD	0kl: $k,l = 2n$

Angles between zone axes

ZA-uvw	ZA	1	2	3	
001	1	-	29.1°	66.1°	Measured
111	2	29.0°	-	37.1°	Calculated
331	3	66.6°	37.6°	-	

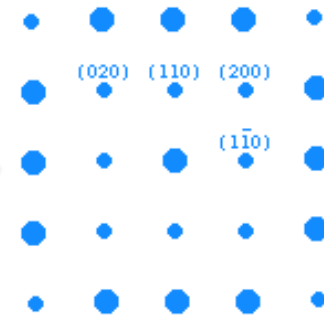
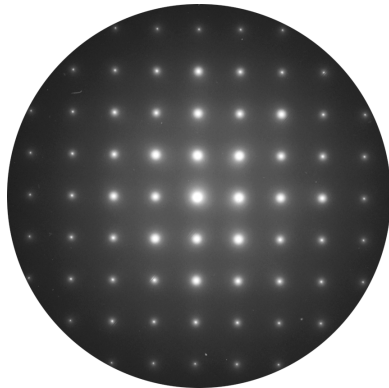
[†] $\text{I}\bar{3}2$, $\text{I}4/\text{mcm}$, $a=6.00\text{\AA}$, $c=11.03\text{\AA}$

^{††} Extinction rules from International Tables of Crystallography, Vol. A

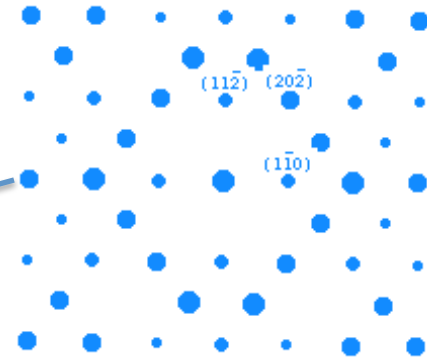
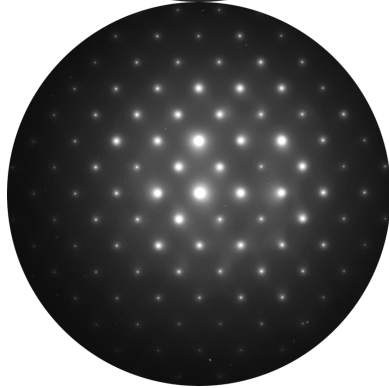
Indexing Example: Mo_5SiB_2

DesktopMicroscopist Simulations

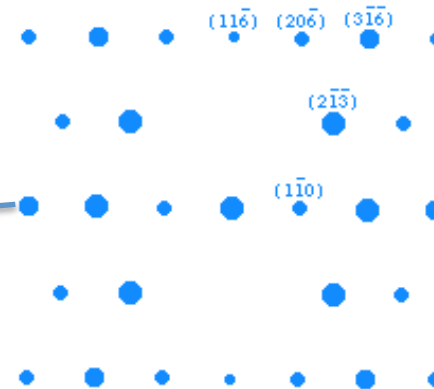
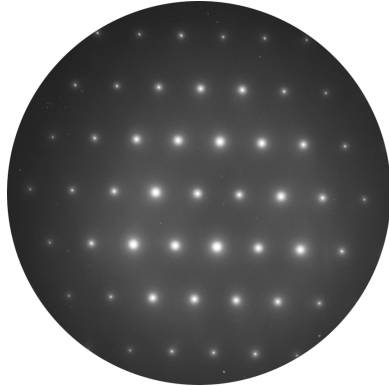
001



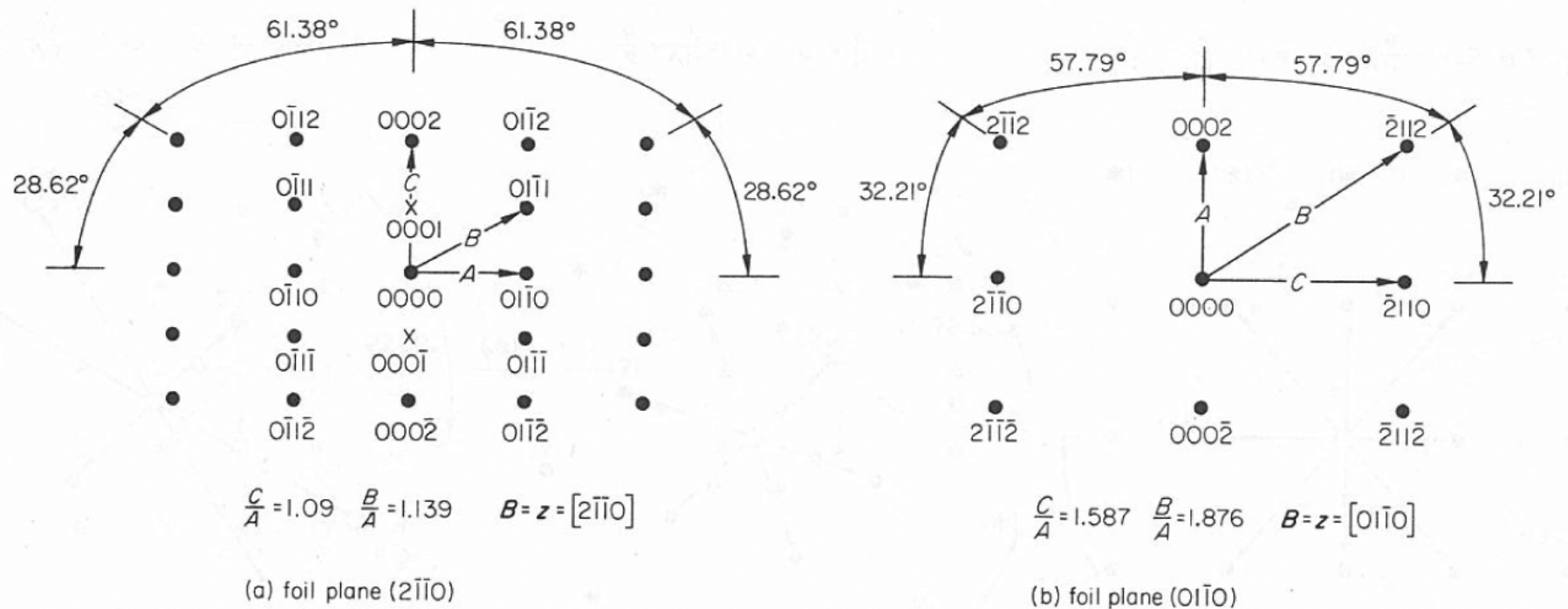
111



331



Dynamic Diffraction: Double Diffraction of (0001) in hcp



Tips:

- Reflection may appear in one ZA, but not another
- Tilt off ZA to systematic row
- Extinction conditions in CBED

(Figure from Edington, "Practical Electron Microscopy in Materials Science")

Precipitates: Orientation Relationship with Single Variant

- Crystallographic orientation relationship (OR) between matrix and precipitate
- Generally designated as direction and plane aligned in M/P:

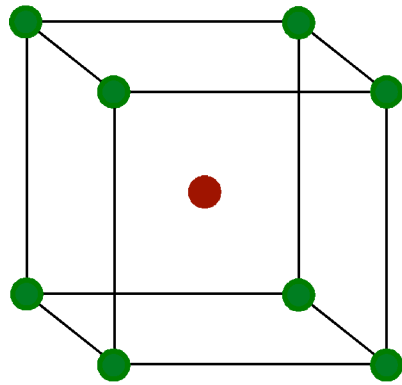
$$\begin{array}{l} [uvw]_P \parallel [uvw]_M \\ (hkl)_P \parallel (hkl)_M \end{array}$$

- Simplest example is “cube-on-cube” (single variant):

$$\begin{array}{l} [001]_P \parallel [001]_M \\ (100)_P \parallel (100)_M \end{array}$$

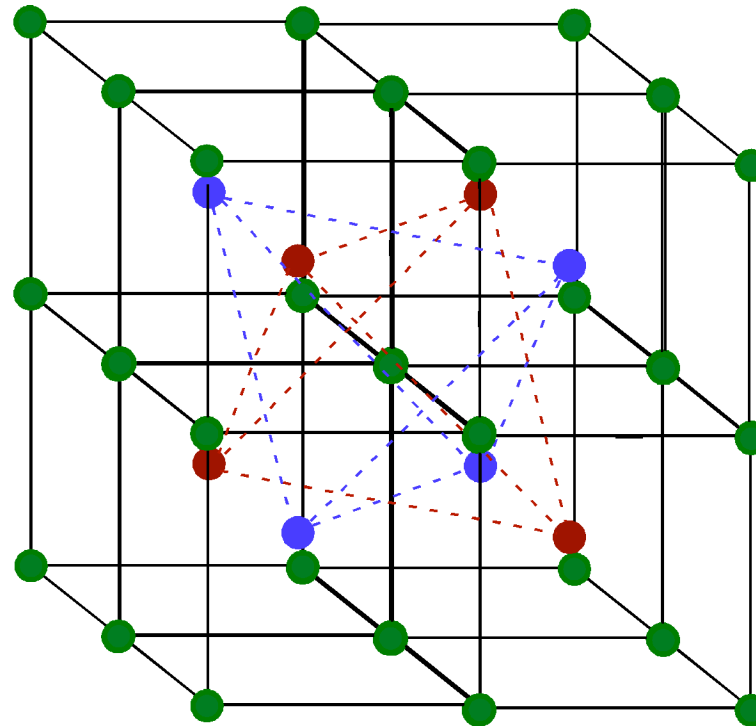
- Tilt on matrix and record diffraction patterns along matrix zone axes

B2 vs. L21: Ordering on Al/Ti Sublattice



NiAl (CsCl-B2)
 $\text{Pm}\bar{3}\text{m}$, cP2

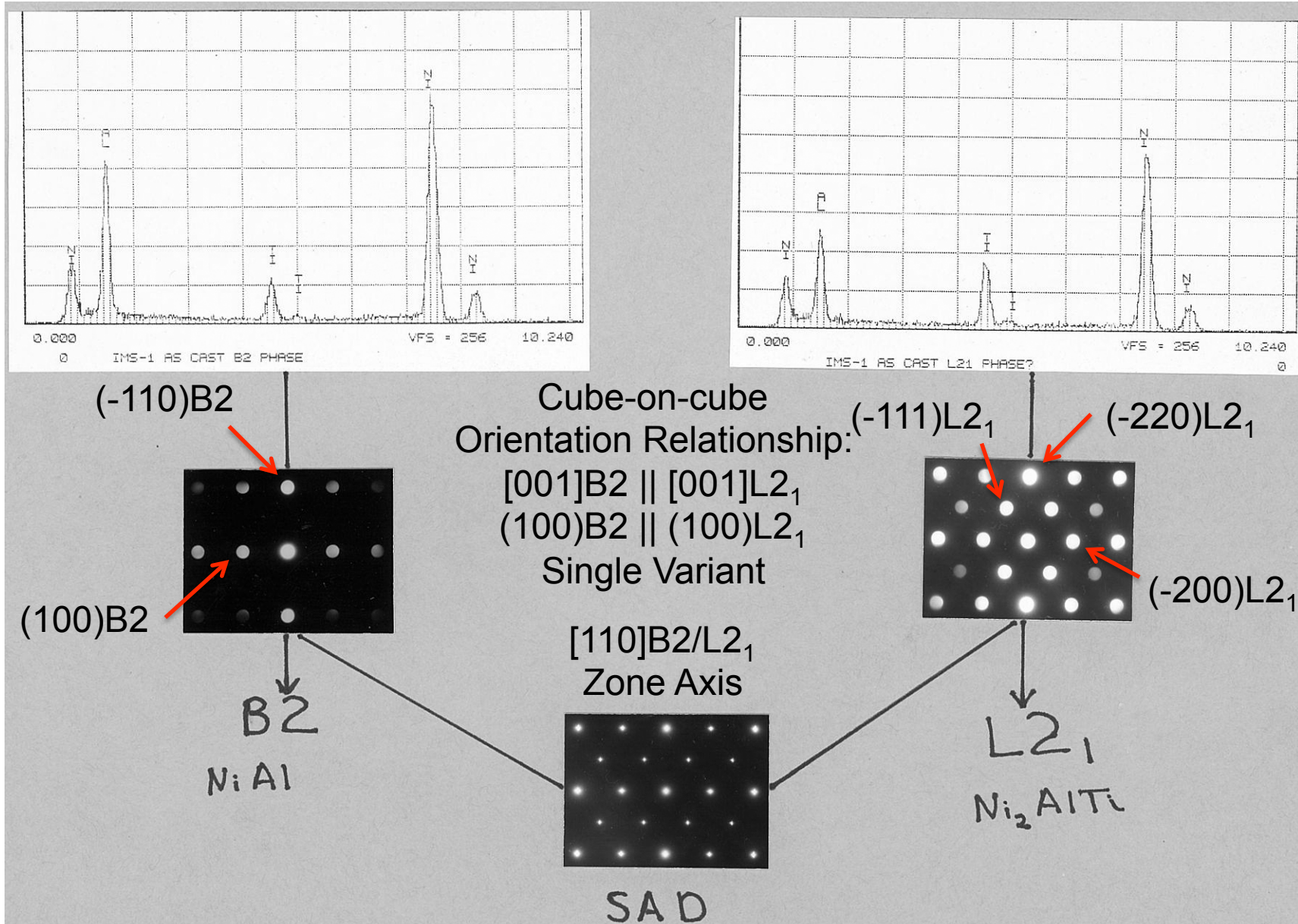
● Ni ● Al/Ti



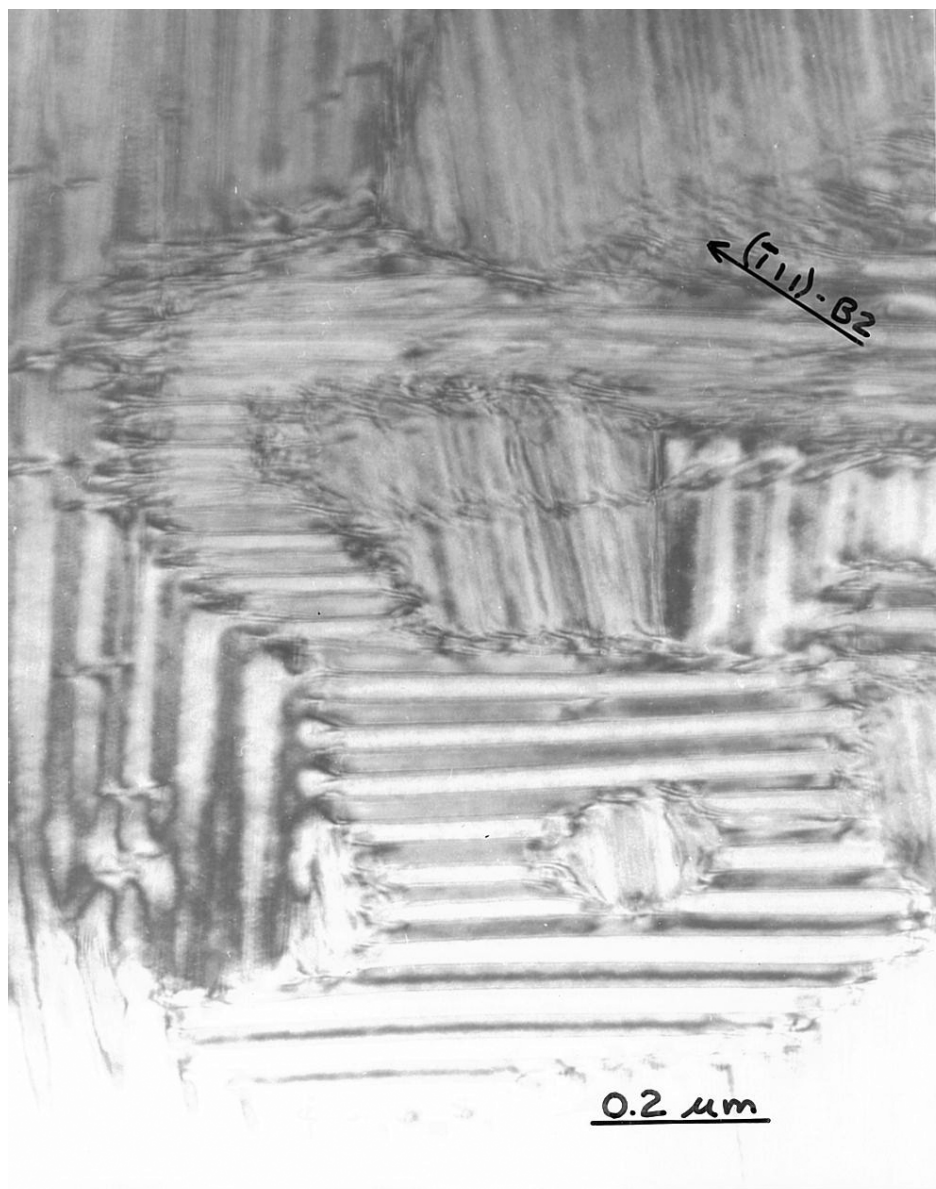
Ni_2AlTi (BiF_3 -L2₁)
Heusler phase
 $\text{Fm}\bar{3}\text{m}$, cF16

● Ni ● Al ● Ti

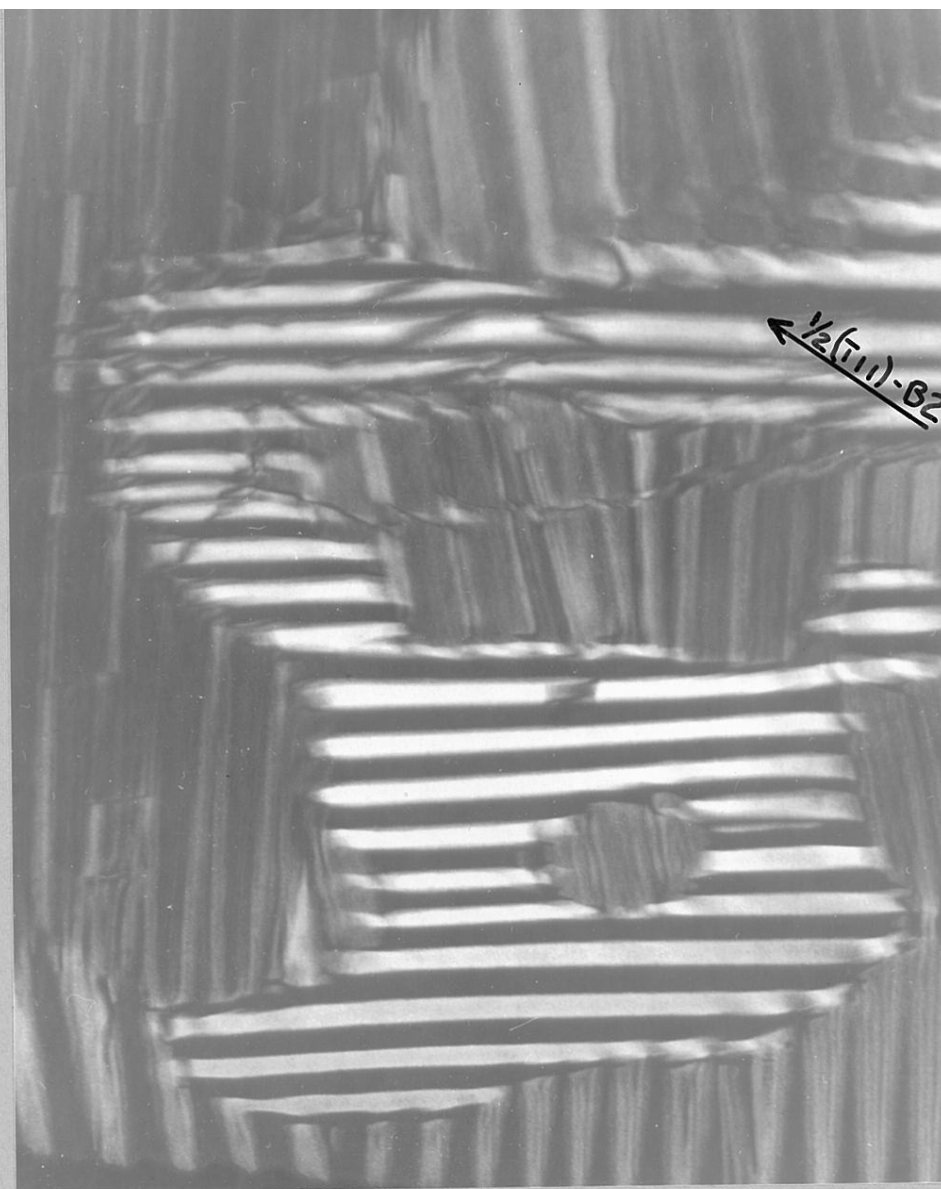
B2/L2₁ Conditional Spinodal Ordering



B2/L2₁ Conditional Spinodal Ordering – Dark Field



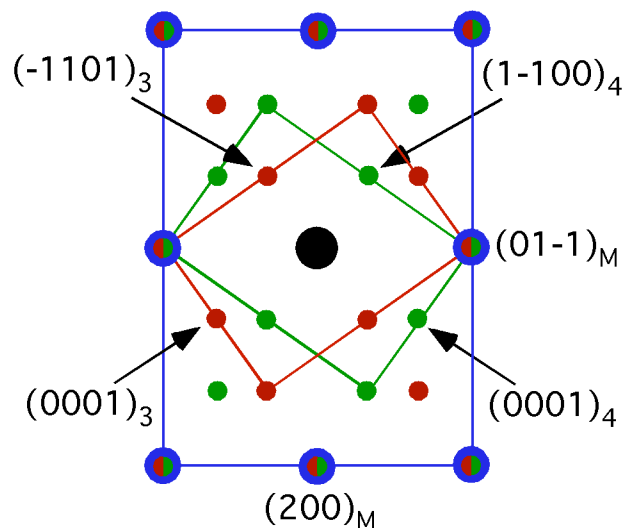
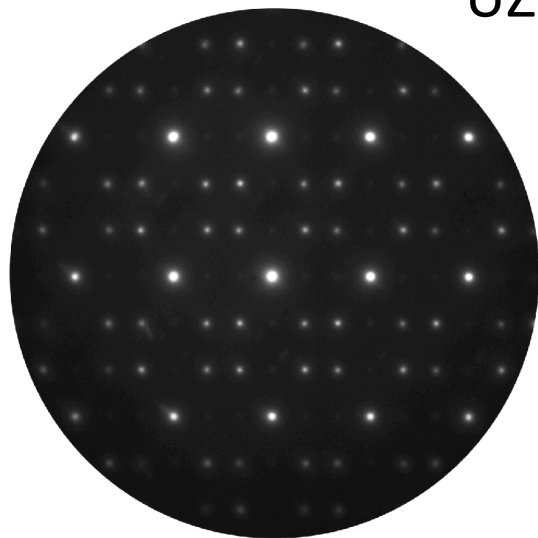
BF



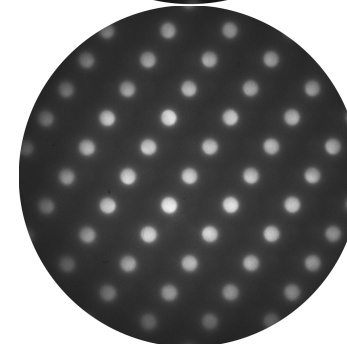
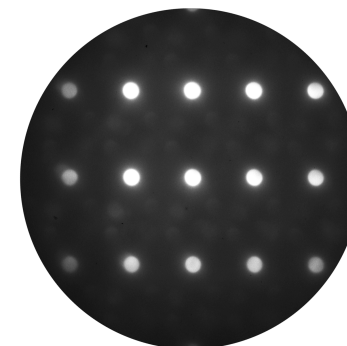
DF

Precipitates: Orientation Relationship with Multiple Variants

UZr₂ Precipitates in γ -U (bcc) Matrix



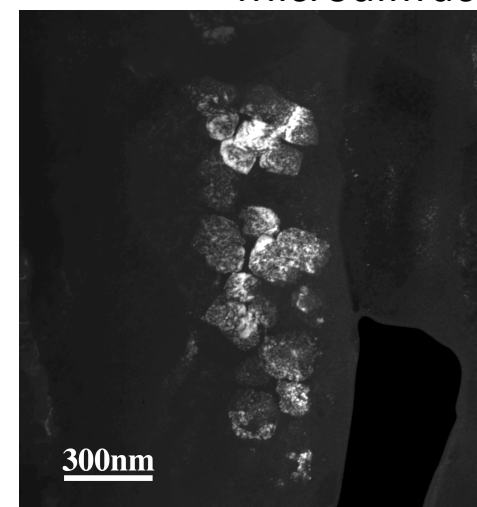
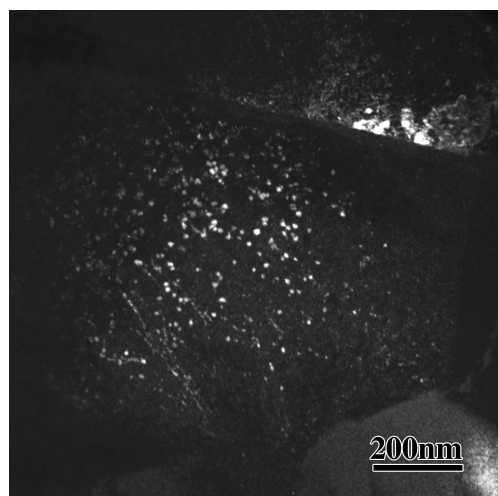
$$[011]_M \parallel [11-20]_3 \parallel [11-20]_4$$



Microdiffraction

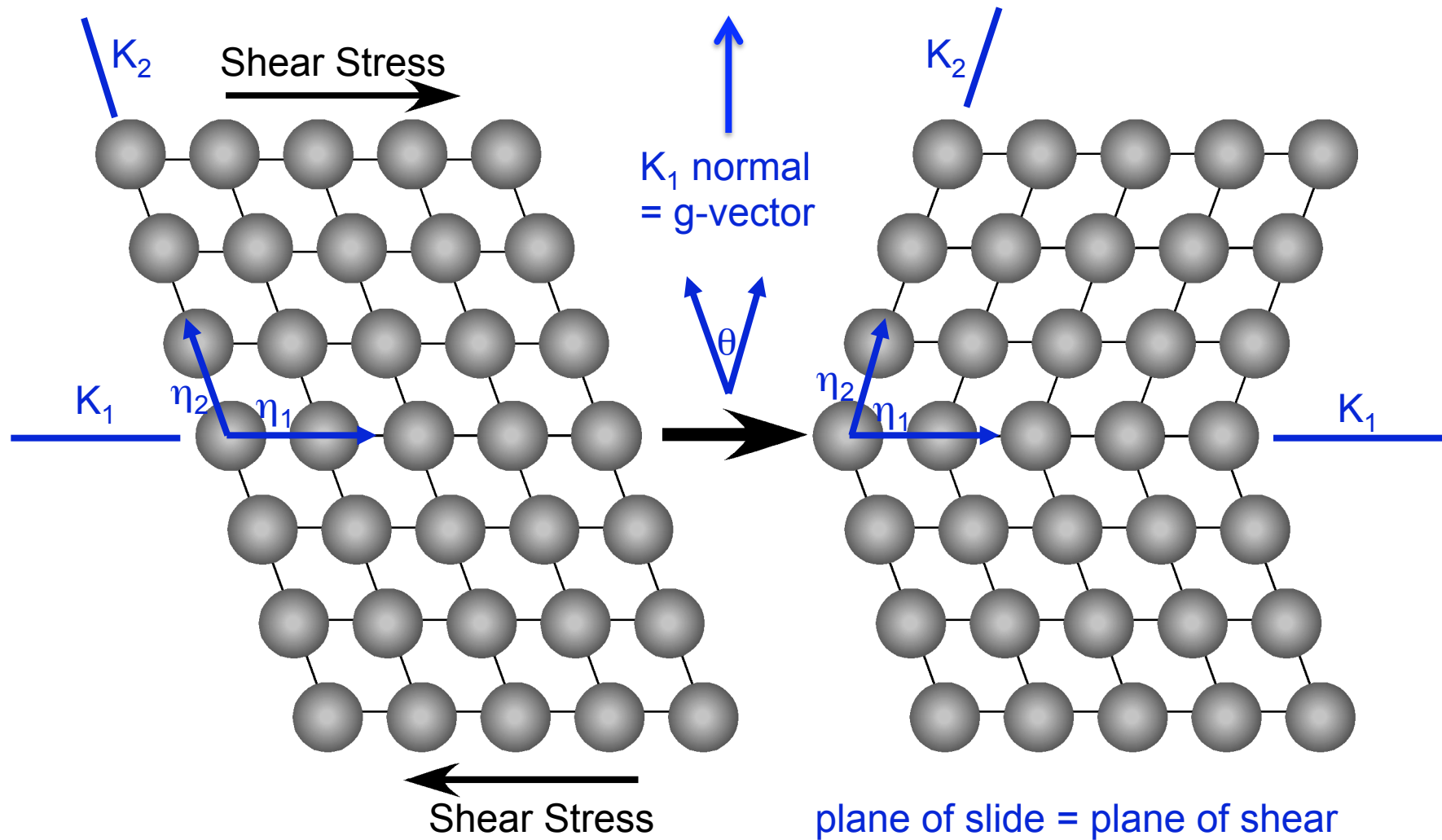
Orientation Relationships

Variant 1	$[111]_\gamma \parallel [0001]_{\text{UZr}_2}$ $(01-1)_\gamma \parallel (11-20)_{\text{UZr}_2}$
Variant 2	$[-111]_\gamma \parallel [0001]_{\text{UZr}_2}$ $(01-1)_\gamma \parallel (11-20)_{\text{UZr}_2}$
Variant 3	$[1-11]_\gamma \parallel [0001]_{\text{UZr}_2}$ $(011)_\gamma \parallel (11-20)_{\text{UZr}_2}$
Variant 4	$[11-1]_\gamma \parallel [0001]_{\text{UZr}_2}$ $(011)_\gamma \parallel (11-20)_{\text{UZr}_2}$

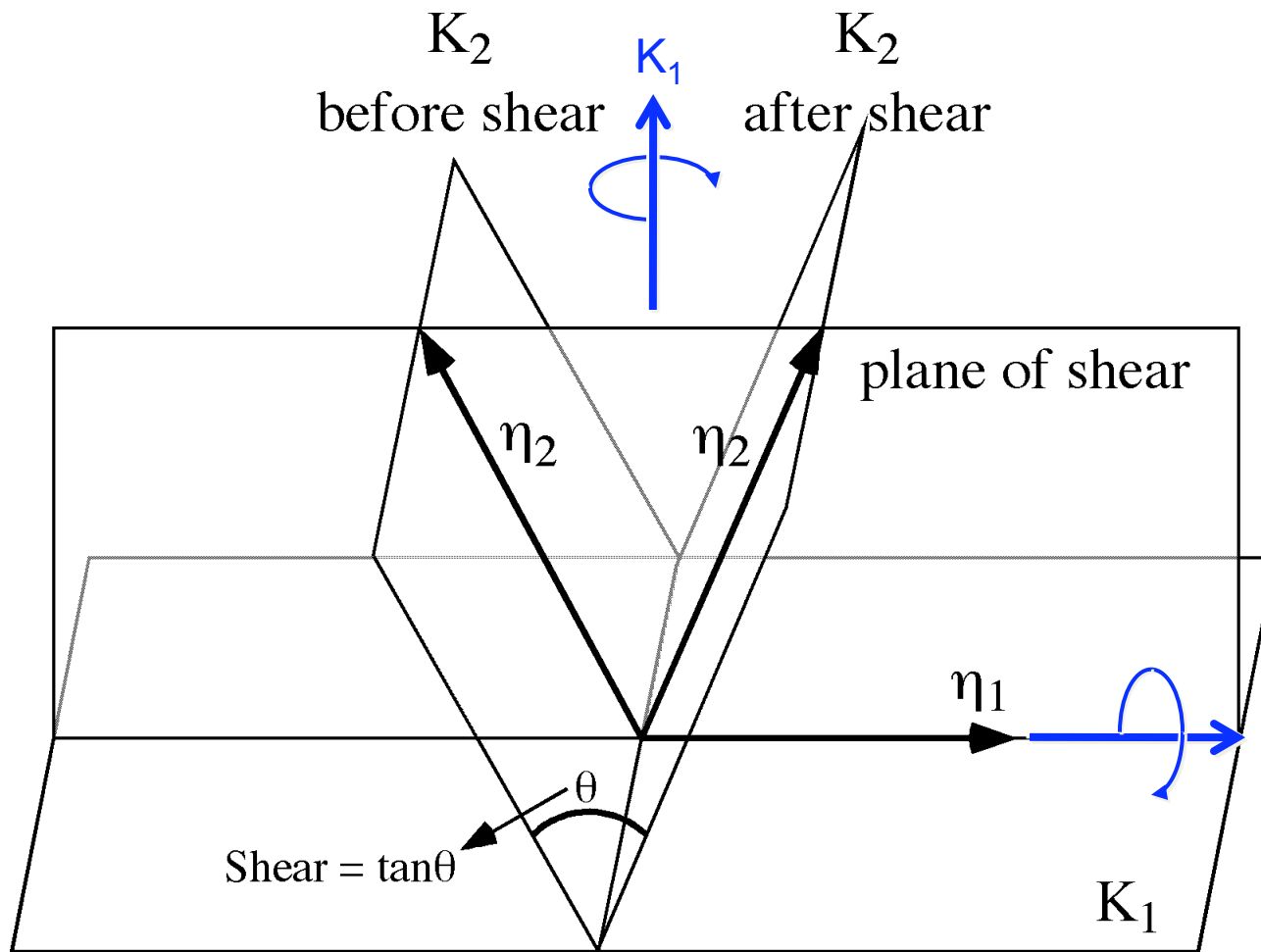


Dark Field Micrographs – doesn't show all variants

Basic Elements of Twinning - Atomistic View



Basic Elements of Twinning



Type I:

- K_1 & η_2 rational
- K_2 & η_1 irrational

Type II:

- K_2 & η_1 rational
- K_1 & η_2 irrational

Compound:

- All elements rational

Reciprocal Twins:

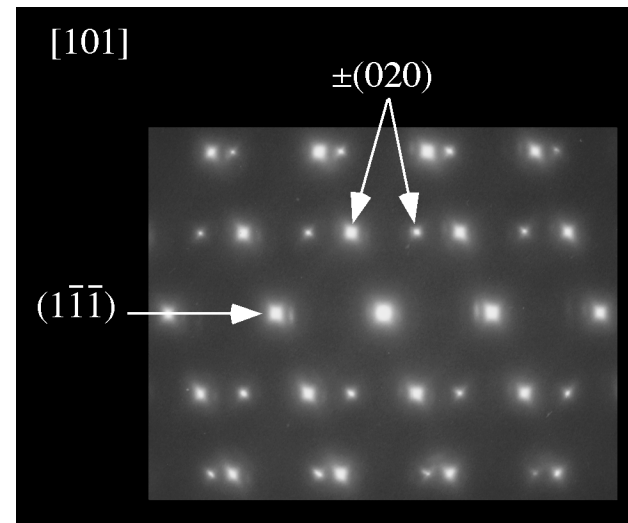
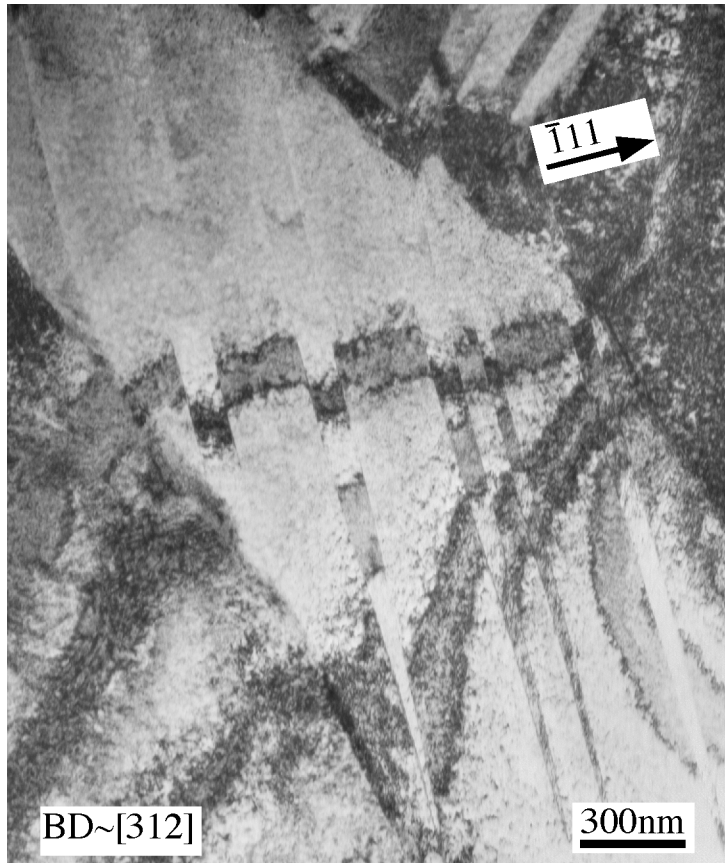
- $K_1 \leftrightarrow K_2$
- $\eta_1 \leftrightarrow \eta_2$

Diffraction Patterns from Twins

- Same phase, different orientation
 - similar to second phase
- Most twins will display diffraction pattern mirrored about K_1 plane
- Tilting hints:
 - 1) Tilt about axis \sim perpendicular to K_1 normal
 - tilt until beam direction is contained within K_1
 - matrix and twin will go dark together when $g\text{-vector} = K_1$
 - 2) Tilt along K_1 to zone axis

Diffraction from Type I or Compound Twin

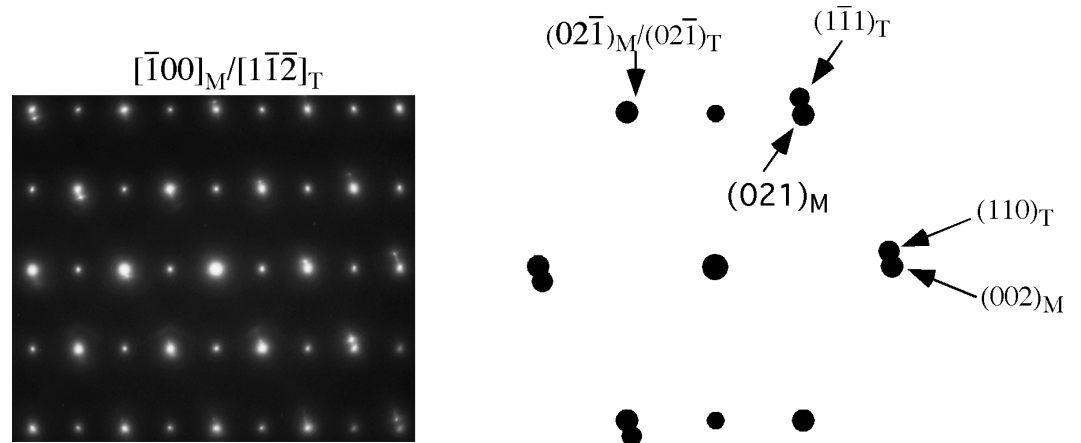
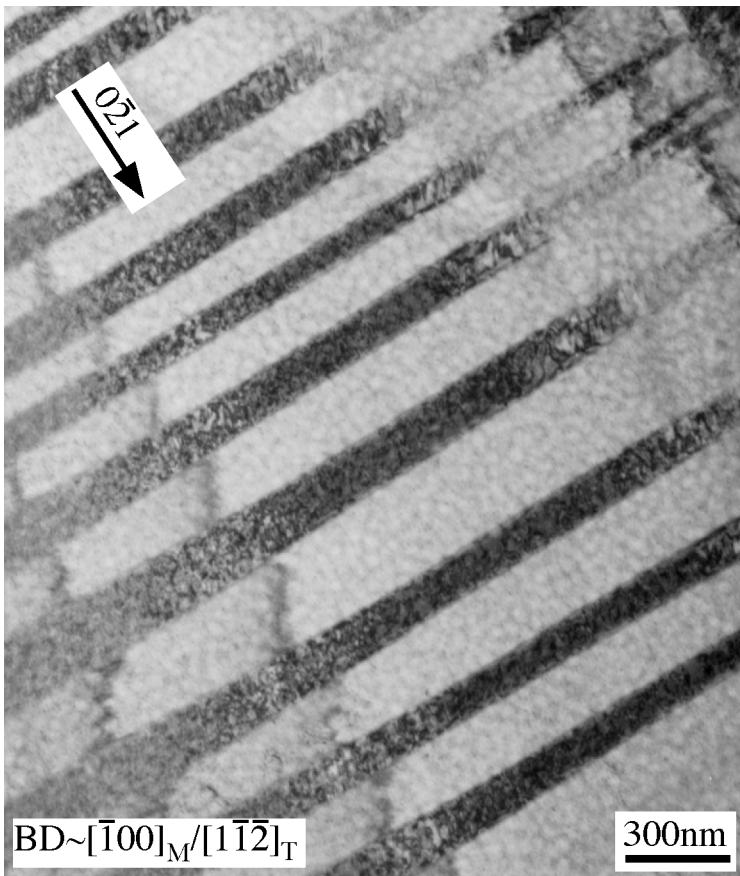
Twin orientation relationship: 180° rotation about K_1



Diffraction pattern from ZA containing twin plane: mirror about twin plane

Diffraction from Type II Twin

Twin orientation relationship: 180° rotation about η_1



Diffraction patterns from twins no longer show mirror symmetry with matrix

A Few More Examples

- Precise lattice parameter measurements with HOLZ lines (High Order Laue Zones)
- Friedel's Law and electron diffraction
- Streaking and spiking
- Amorphous/fine grain polycrystalline patterns

Using HOLZ lines
to measure γ/γ'
lattice mismatch
in a Ni-Base
Superalloy

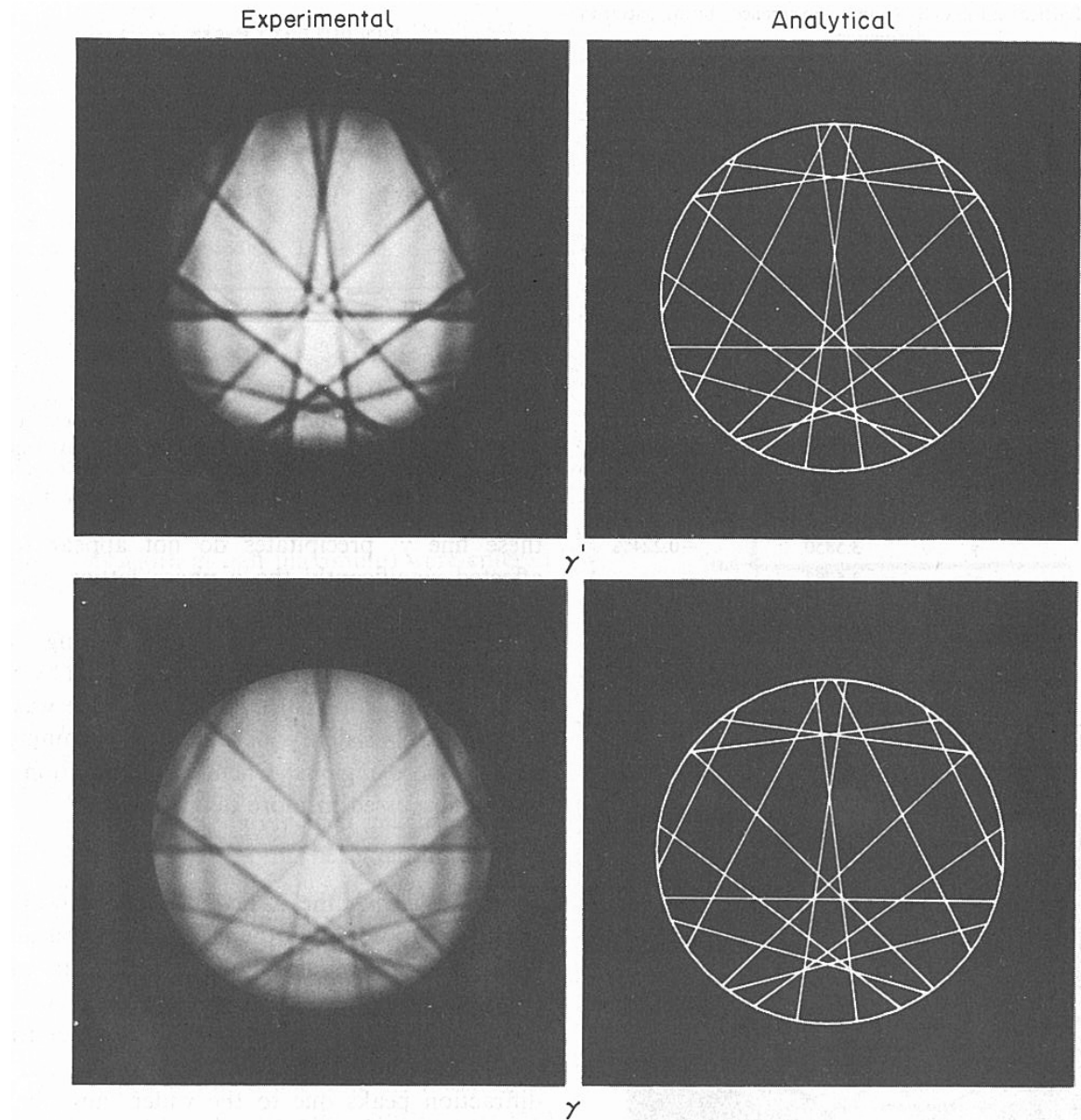
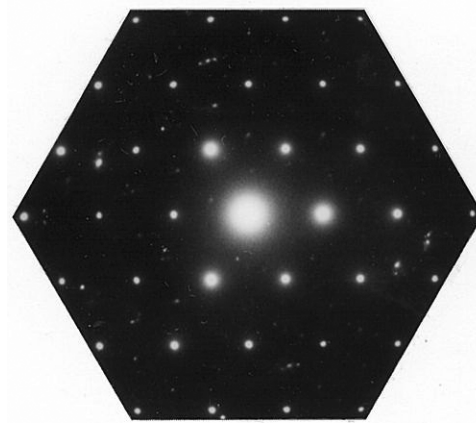


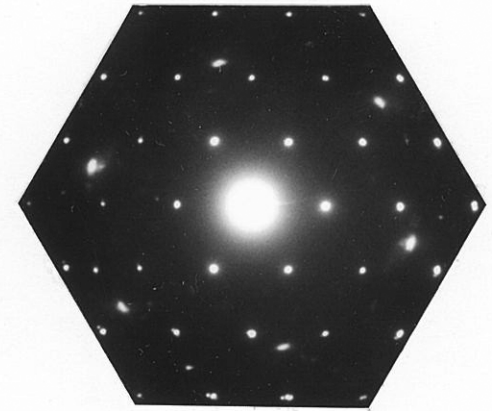
Fig. 7. Experimental and analytical FOLZ line patterns from the $[114]$ zone axis for the alloy in the over-age condition. The lattice parameter of each phase is: $\gamma = 3.5840 \text{ \AA}$, $\gamma' = 3.5765 \text{ \AA}$. The lattice mismatch for this pair is -0.21% .

Structure Lacking Center of Symmetry (Friedel's Law)

SAD: Thin region is more Kinematic
Thick region is more Dynamical

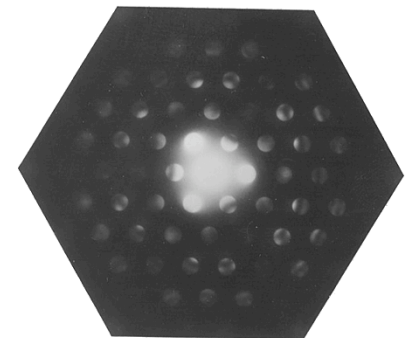
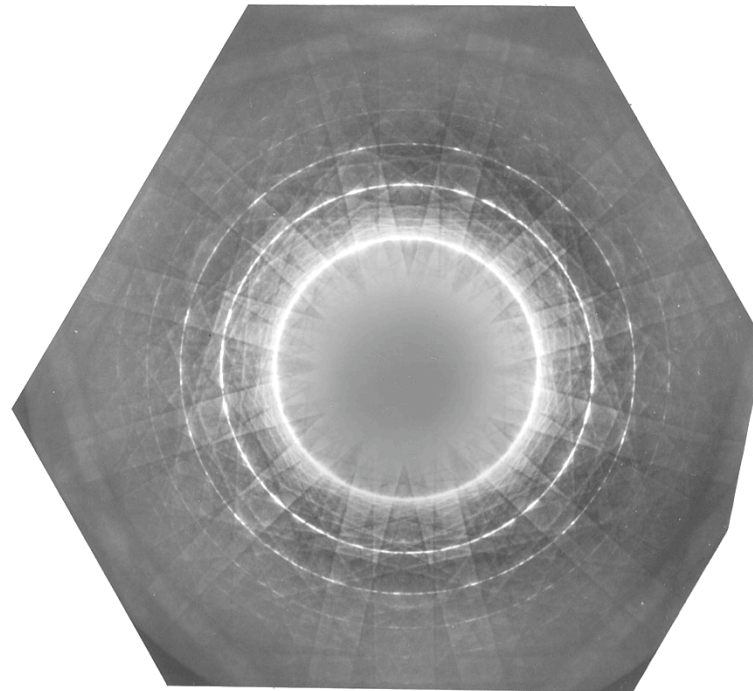


Thick Region

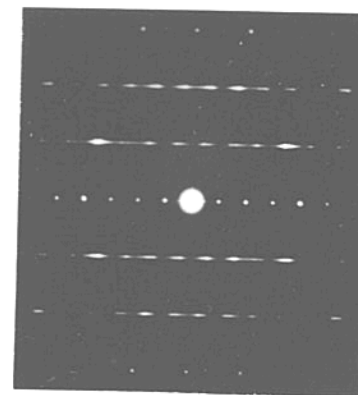
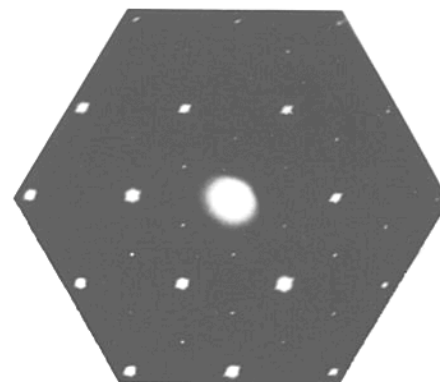
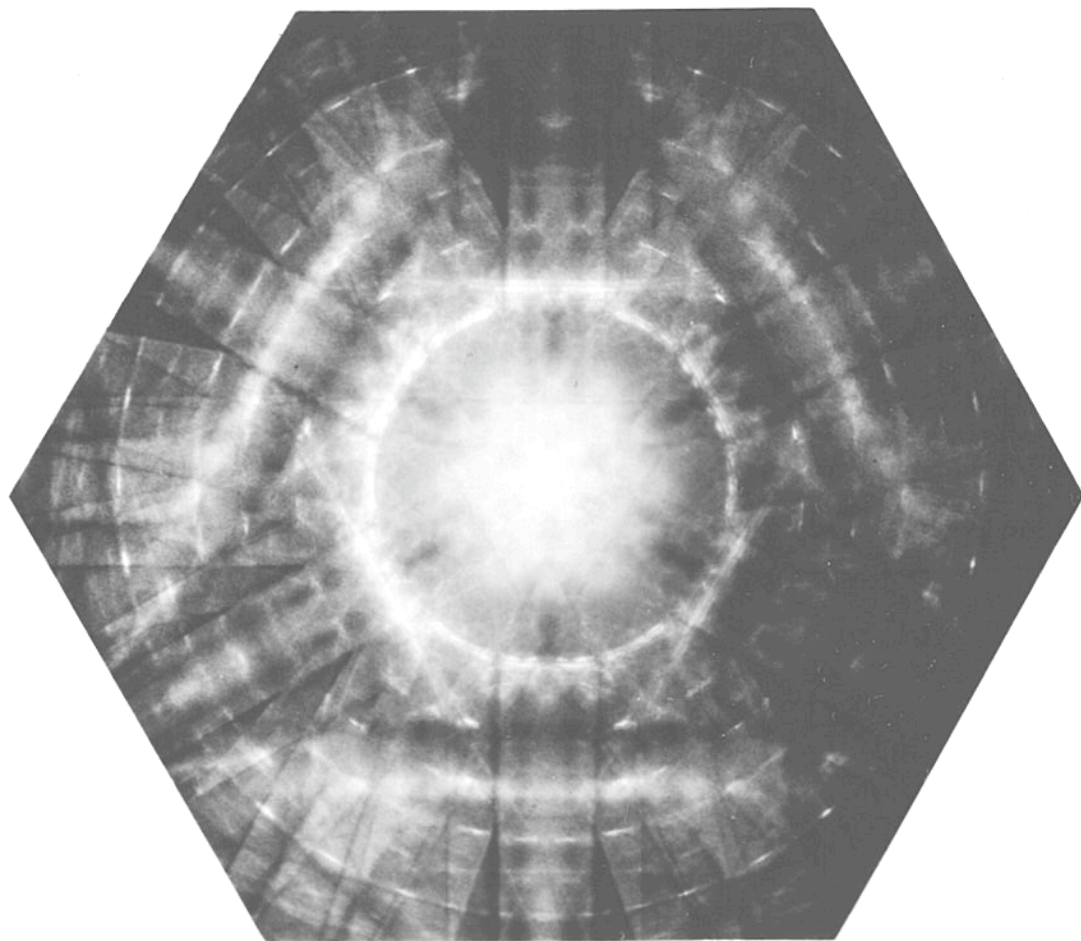


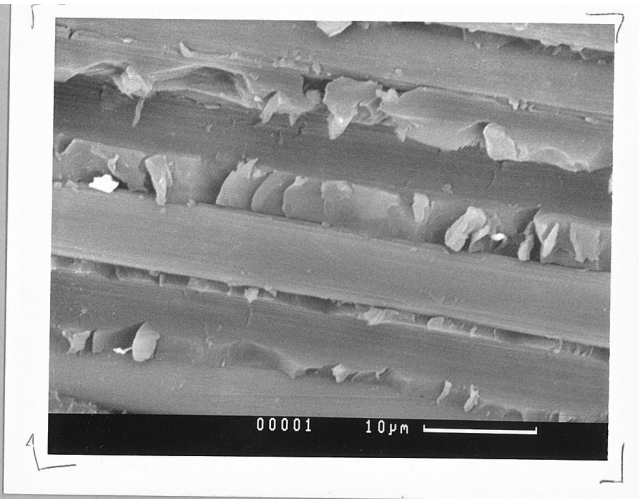
Thin Region

Convergent Beam



Mu Phase in Ni Base Superalloy: Streaking/Spiking of RL Points

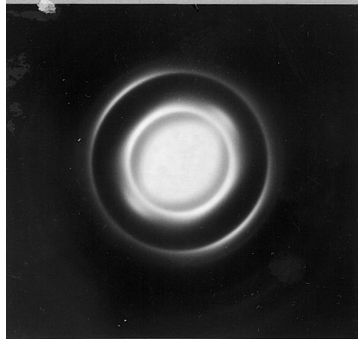




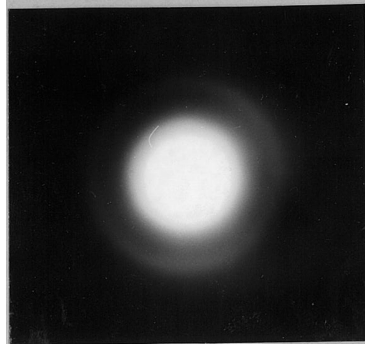
Carbon-Carbon Composite

Amorphous Matrix

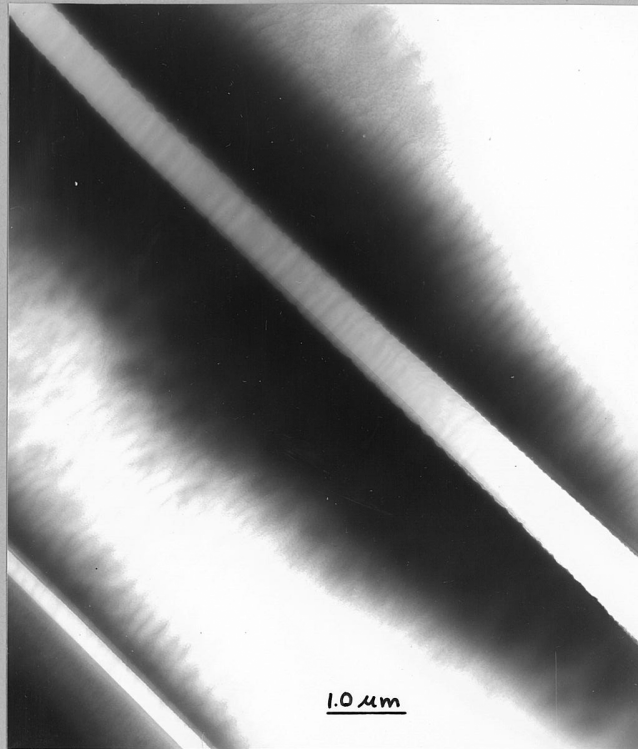
Fine-grained textured fibers



Fiber

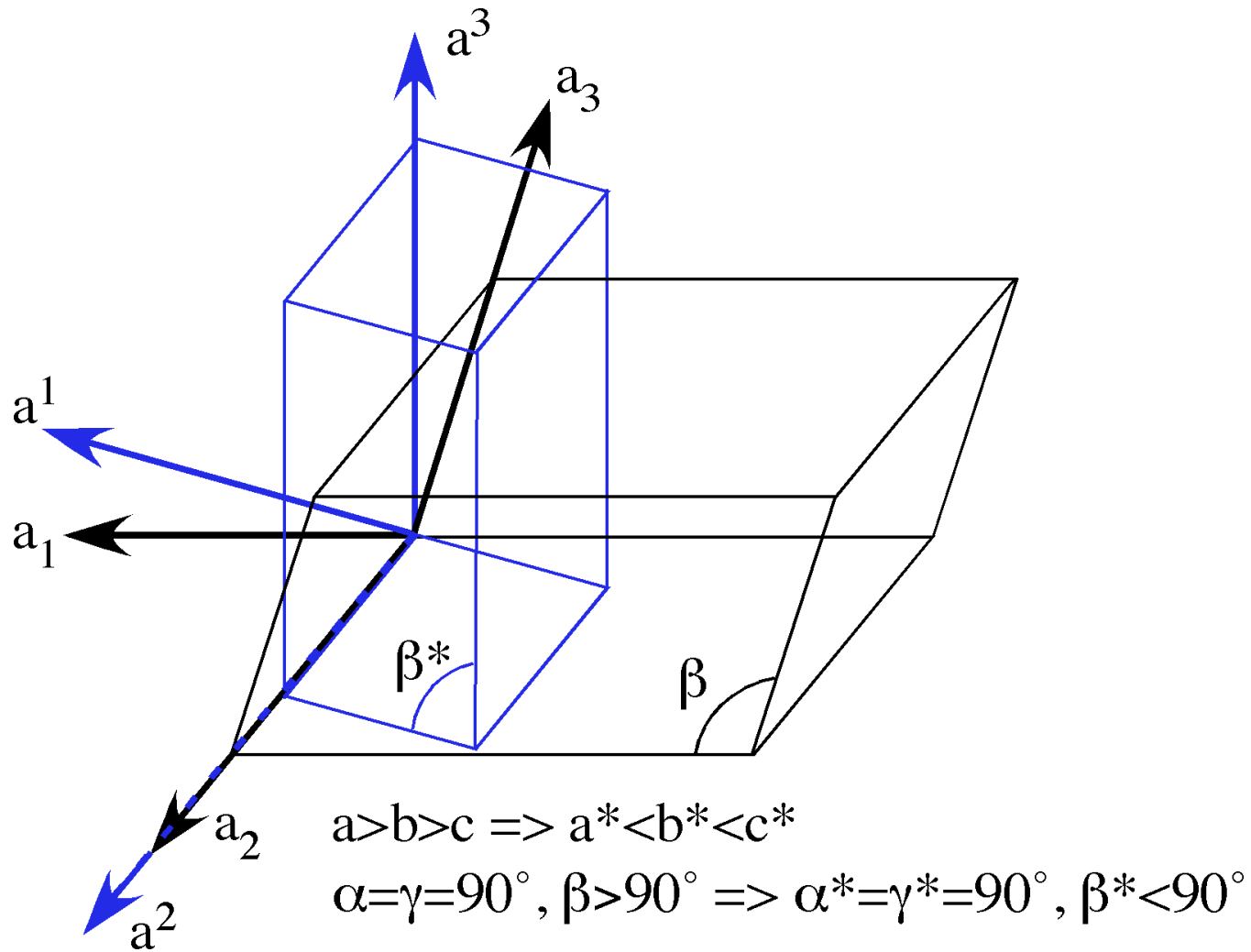


Matrix

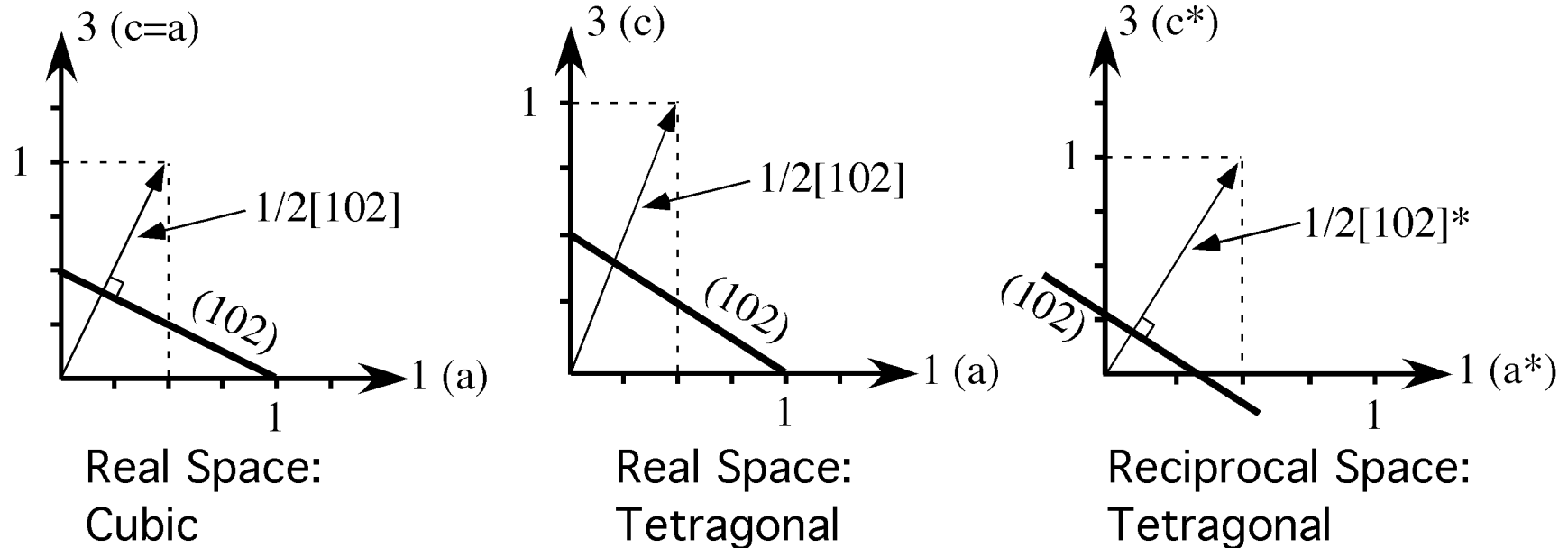


Questions?

Real vs. Reciprocal Space Unit Cells



Directions vs. Poles (plane normals) Real vs. Reciprocal Space



Directions in reciprocal space (poles) are always normal to planes in real space with same indices (and vice-versa)